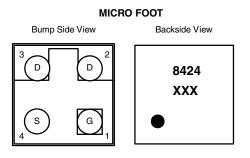


## N-Channel 1.2 V (G-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	<b>R<sub>DS(on)</sub> (</b> Ω <b>)</b>	Q <sub>g</sub> (Typ.)				
8	0.031 at V <sub>GS</sub> = 4.5 V	12.2				
	0.033 at $V_{GS}$ = 2.5 V	11.6				
	0.035 at V <sub>GS</sub> = 1.8 V	11.2	20 nC			
	0.043 at V <sub>GS</sub> = 1.5 V	10.2				
	0.077 at V <sub>GS</sub> = 1.2 V	1.3				



Device Marking: 8424 xxx = Date/Lot Traceability Code

Ordering Information: Si8424DB-T1-E1 (Lead (Pb)-free and Halogen-free)

### **FEATURES**

- TrenchFET<sup>®</sup> Power MOSFET
- Industry First 1.2 V Rated MOSFET
- Ultra Small MICRO FOOT<sup>®</sup> Chipscale Packaging Reduces Footprint Area, Profile (0.62 mm) and On-Resistance Per Footprint Area

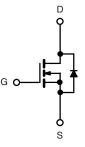


COMPLIANT HALOGEN FREE

Material categorization: For definitions of compliance ٠ please see www.vishay.com/doc?99912

#### **APPLICATIONS**

- · Low Threshold Load Switch for Portable Devices
  - Low Power Consumption
  - Increased Battery Life
- Ultra Low Voltage Load Switch



N-Channel MOSFET

ABSOLUTE MAXIMUM RATING				
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	8	V	
Gate-Source Voltage		V <sub>GS</sub>	± 5	v
	T <sub>C</sub> = 25 °C		12.2	
Continuous Drain Current (T = $150 ^{\circ}$ C)	T <sub>C</sub> = 70 °C		9.8	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	8.1 <sup>b,c</sup>	
	T <sub>A</sub> = 70 °C		6.5 <sup>b,c</sup>	А
Pulsed Drain Current	·	I <sub>DM</sub>	20	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	1	5.2	
	T <sub>A</sub> = 25 °C	I <sub>S</sub>	2.3 <sup>b,c</sup>	
	T <sub>C</sub> = 25 °C		6.25	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	В	4	
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.78 <sup>b,c</sup>	W
	T <sub>A</sub> = 70 °C		1.78 <sup>b,c</sup>	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C
Package Reflow Conditions <sup>d</sup>	IR/Convection		260	

Notes:

a. Based on  $T_C = 25 \ ^{\circ}C$ .

b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Refer to IPC/JEDEC (J-STD-020), no manual or hand soldering.

e. In this document, any reference to the Case represents the body of the MICRO FOOT device and Foot is the bump.



THERMAL RESISTANCE RATINGS								
Parameter	Symbol	Тур.	Max.	Unit				
Maximum Junction-to-Ambient <sup>a,b</sup>	R <sub>thJA</sub>	35	45	°C/W				
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	16	20				

Notes

a. Surface mounted on 1" x 1" FR4 board.

b. Maximum under steady state conditions is 72  $^{\circ}\text{C/W}.$ 

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static			•				
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_D = 250 \mu A$	8			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		8.9			
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 2.5		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	0.35		1	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = 5 V$			100	nA	
Zaus Oats Maltage Dusin Oursent		$V_{DS} = 8 V, V_{GS} = 0 V$			1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS}$ = 8 V, $V_{GS}$ = 0 V , $T_{J}$ = 70 °C			10	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \leq 5$ V, $V_{GS}$ = 4.5 V	20			Α	
		$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 1 \text{ A}$		0.025	0.031	Ω	
	R <sub>DS(on)</sub>	$V_{GS} = 2.5 \text{ V}, \text{ I}_{D} = 1 \text{ A}$		0.027	0.033		
Drain-Source On-State		V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 1 A		0.029	0.035		
Resistance <sup>a</sup>		V <sub>GS</sub> = 1.5 V, I <sub>D</sub> = 1 A		0.032	0.043		
		V <sub>GS</sub> = 1.2 V, I <sub>D</sub> = 1 A		0.049	0.077		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 4 V$ , $I_D = 1 A$		8.3	13	S	
Dynamic <sup>b</sup>	1. I.						
Input Capacitance	C <sub>iss</sub>			1950			
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ = 4 V, $V_{GS}$ = 0 V, f = 1 MHz		610		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			350			
Tatal Cata Charge	0	$V_{DS} = 4 V, V_{GS} = 5 V, I_{D} = 1 A$		22	33		
Total Gate Charge	Qg	V <sub>DS</sub> = 4 V, V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 1 A		20	30	-	
Gate-Source Charge	Q <sub>gs</sub>			3.5		nC	
Gate-Drain Charge	Q <sub>gd</sub>			1.8		7	
Gate Resistance	R <sub>g</sub>	V <sub>GS</sub> = 0.1 V, f = 1 MHz		13		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			8	12		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 4 V, $R_L$ = 4 $\Omega$		12	18	1	
Turn-Off Delay Time	t <sub>d(off)</sub>	$\rm I_D \cong 1$ A, $\rm V_{GEN}$ = – 4.5 V, $\rm R_g$ = 1 $\Omega$		110	165	ns	
Fall Time	t <sub>f</sub>			40	60	1	

Document Number: 74400 S13-1847-Rev. C, 19-Aug-13

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<b>SPECIFICATIONS</b> ( $T_J = 25 \text{ °C}$ , unless otherwise noted)								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			6.25	^		
Pulse Diode Forward Current	I <sub>SM</sub>				20	A		
Body Diode Voltage	V <sub>SD</sub>	$I_{\rm S} = 1$ A, $V_{\rm GS} = 0$ V		0.6	1.2	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>			104	156	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = – 1 A, dl/dt = 100 A/μs, T <sub>1</sub> = 25 °C		88	132	nC		
Reverse Recovery Fall Time	t <sub>a</sub>	$F = 123, a_0 a_1 = 100 A/\mu s, T_1 = 25 0$		26		ns		
Reverse Recovery Rise Time	t <sub>b</sub>			78		115		

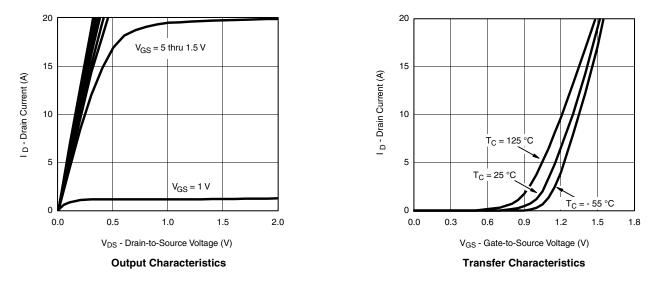
Notes:

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

#### TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C, unless otherwise noted)

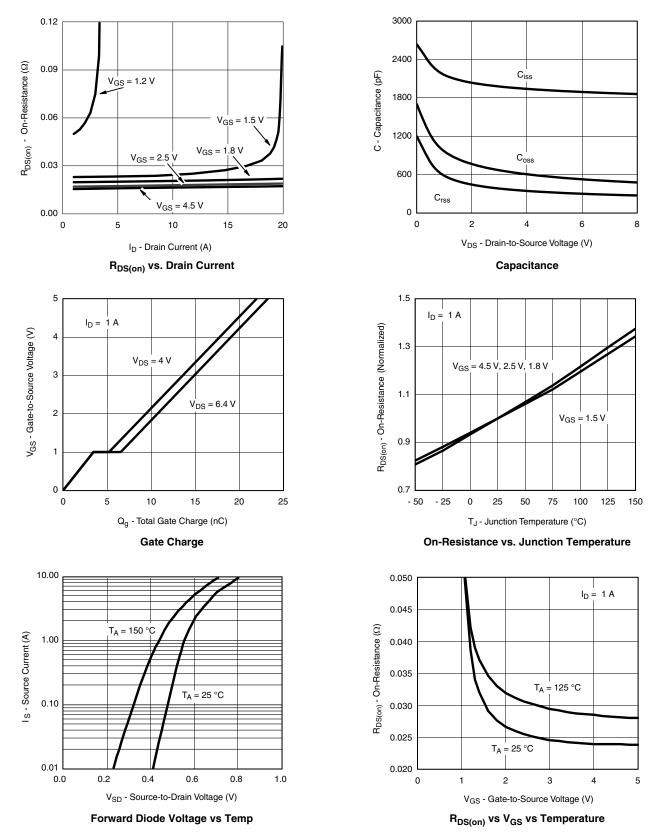


# Si8424DB

## Vishay Siliconix



### **TYPICAL CHARACTERISTICS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)



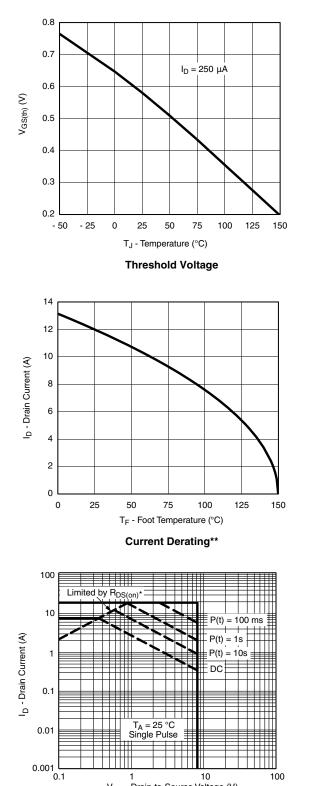
For technical questions, contact: pmostechsupport@vishay.com

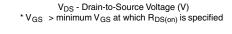
Document Number: 74400 S13-1847-Rev. C, 19-Aug-13

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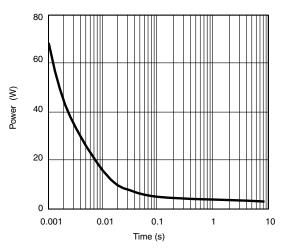


### **TYPICAL CHARACTERISTICS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)

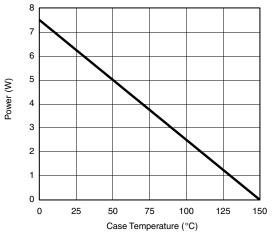




Safe Operating Area, Junction-to-Ambient



Single Pulse Power, Junction-to-Ambient

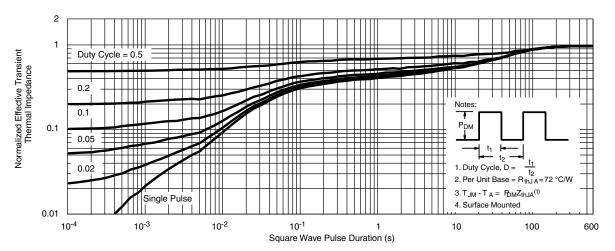


**Power Derating** 

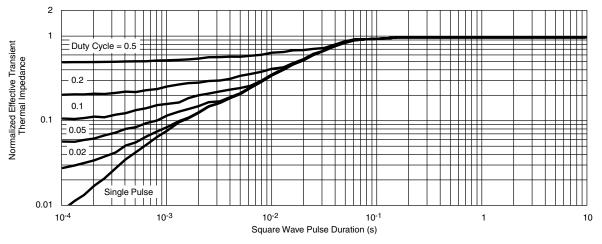
\*\* The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-tofoot thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



### **TYPICAL CHARACTERISTICS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

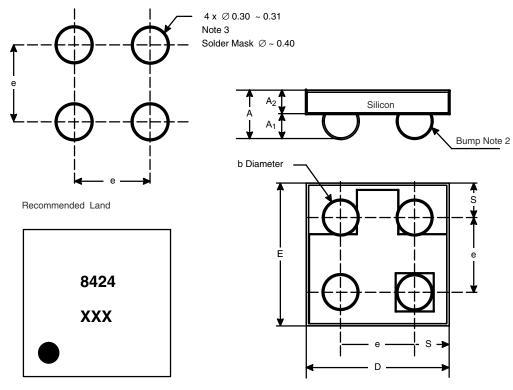


Si8424DB Vishay Siliconix

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#### **PACKAGE OUTLINE**

MICRO FOOT: 4-BUMP (0.8-mm PITCH)



Mark on Backside of Die

Notes (unless otherwise specified):

1. Laser mark on the silicon die back, coated with a thin metal.

2. Bumps are Sn/Ag/Cu.

3. Non-solder mask defined copper landing pad.

4. The flat side of wafers is oriented at the bottom.

Dim.	Millimeters <sup>a</sup>		Inches		
	Min.	Max.	Min.	Max.	
Α	0.600	0.650	0.0236	0.0256	
A <sub>1</sub>	0.260	0.290	0.0102	0.0114	
A <sub>2</sub>	0.340	0.360	0.0134	0.0142	
b	0.370	0.410	0.0146	0.0161	
D	1.520	1.600	0.0598	0.0630	
E	1.520	1.600	0.0598	0.0630	
е	0.800		0.0315		
S	0.360	0.400	0.0142	0.0157	

Note:

a. Use millimeters as the primary measurement.

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